

**Search Notes**

Application/Control No.

10/526,341

Examiner

Julie Lieu

Applicant(s)/Patent under  
Reexamination

CHYUN, CHAN HYUK

Art Unit

2612

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	12/22/2006	JL